



<p style="text-align: center;">Searched</p> 	<p>Application/Control No.</p> <p>10709075</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>WU, YUAN-HSUN</p>
	<p>Examiner</p> <p>Rossoshek, Helen</p>	<p>Art Unit</p> <p>2825</p>


Class	SubClass	Date	Examiner
716	4,19,21	06/06/2006	HR
438	396,243	06/06/2006	HR
430	22,30,312	06/06/2006	HR
382	211	06/06/2006	HR
356	450,401,335,237.1,124	06/06/2006	HR
355	67	06/06/2006	HR
257	208.1	06/06/2006	HR
UPDATED	UPDATED	10/27/2006	HR

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Interference Searched 	Application/Control No. 10709075	Applicant(s)/Patent Under Reexamination WU, YUAN-HSUN
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716	19	10/30/2006	HR
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Search Notes 	Application/Control No. 10709075	Applicant(s)/Patent Under Reexamination WU, YUAN-HSUN
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Notes	Date	Examiner
EAST (USPAT: US-PGPUB: EPO: JPO: DERWENT: IBM_TDB)	06/06/2006	HR
IEEE	06/06/2006	HR
EAST (US-PGPUB), see search history printout	10/27/2006	HR
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